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Application/Control No.	Applicant(s)/Patent ur Reexamination	ider
10/520,424	KOBAYASHI ET AL.	
Examiner	Art Unit	
Michael A Friedhofer	2832	

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Class	Subclass	Date	Examiner
200	5a,511, 512,516, 517,406	4/12/2006	MAF
341	22	4/12/2006	MAF
345	168	4/12/2006	MAF
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INTERFERENCE SEARCHED		
Subclass	Date	Examiner
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interference search: see search history	4/12/2006	MAF